

<b>Search Notes</b>				Application/Control No.	Applicant(s)/Patent under Reexamination
				10/075,054	YOUSSEF, NABIL R.
				Examiner	Art Unit
				Erin M. File	<i>2611 2034</i>

SEARCHED			
Class	Subclass	Date	Examiner
375	340	2/27/2006	EMF
375	233	3/25/2006	EMF
375	316	2/28/2006	EMF
375	350	3/25/2006	EMF
375	224	3/25/2006	EMF
375	229	3/25/2006	EMF
375	232	3/25/2006	EMF
375	285	3/25/2006	EMF
375	346	3/25/2006	EMF
375	348	3/25/2006	EMF

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only— see search history printout)	2/27/2006	EMF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PBPUB Text Search—see printout history	2/25/2006	EMF	